Spring-loaded test probe **GKS-001 307 150 A 1000** Item GKS-001-0016





- Robust, compact design for harsh ICT/FCT applications with limited space
- For optimum contact at the test points (e.g. pads, vias, and pins), various tip styles in different diameters and finishes, as well as various spring forces are available. spring forces.

General data

ICT / FCT (in-circuit test and function test Product group Sub-product group Short/robust GKS GKS-001 Series Grid 1.91 mm [75 mil] Contacting from Pad, via Magnetic Yes Installation type Plug-in Quick-exchange system Yes Adjustable installation height Nο Non-rotating No Compatible receptacle(s) KS-001 Min. temperature - 40 °C [- 104 °F] Max. temperature + 80 °C [+ 176 °F] RoHS-compliant RoHS-3;6c



Current load capacity / rated current 4 A Typical resistance (Ri) <20 mOhm



 Total length
 17 mm [.669 in]

 Barrel diameter
 1 mm [.039 in]

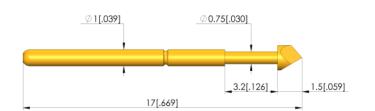
 Maximum stroke
 3 mm [.118 in]

 Spring pre-load
 0.33 N [1.18 ozf]

 Collar height
 00

 Spring force at working stroke
 1 N [3.59 ozf]

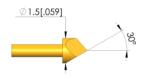
 Recommended working stroke
 2.4 mm [.094 in]



Tip style data

Tip style 07 90° 3-edged chisel, self-cleaning
Tip diameter 1.5 mm [.059 in]
Tip style surface A gold
Tip style material 3 CuBe



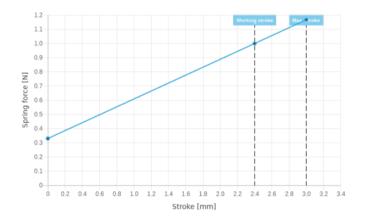


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Learn more about ICT/FCT Test probes

